

Characterization of ParTI Phoswiches Using Charged Pion Beams

E. Churchman^{a,b}, A. Zarrella^a, M. Youngs^a, S. Yennello^a

^a*Cyclotron Institute, Texas A&M University, College Station, Texas 77843, USA*

^b*Department of Physics, Texas Lutheran University, Seguin, Texas 78155, USA*

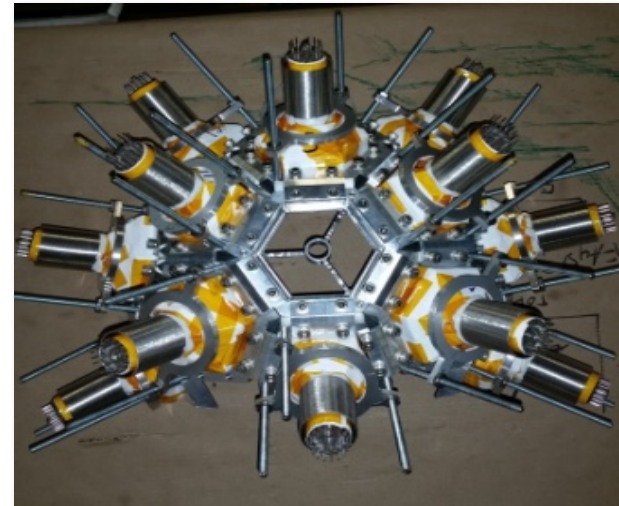
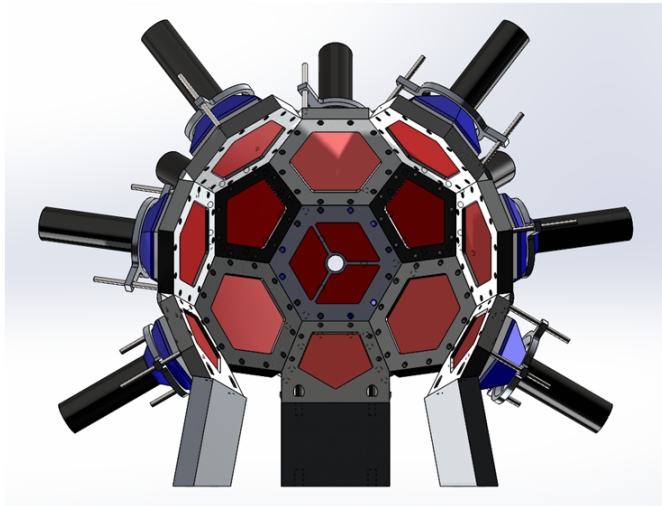


Motivation and Background

- Partial Truncated Icosahedron (ParTI) detector array consists of phoswiches and is designed to measure charged pions (π) emitted in pionic fusion reactions
- Pulse shape discrimination (PSD) particle identification (PID) can be achieved for light charged particles using fast vs. slow pulse shape discrimination
- π also identified by the characteristic decay pulse of their muon (μ) daughters
- 4 phoswiches at PSI
 - π^+ , π^- , and proton beams

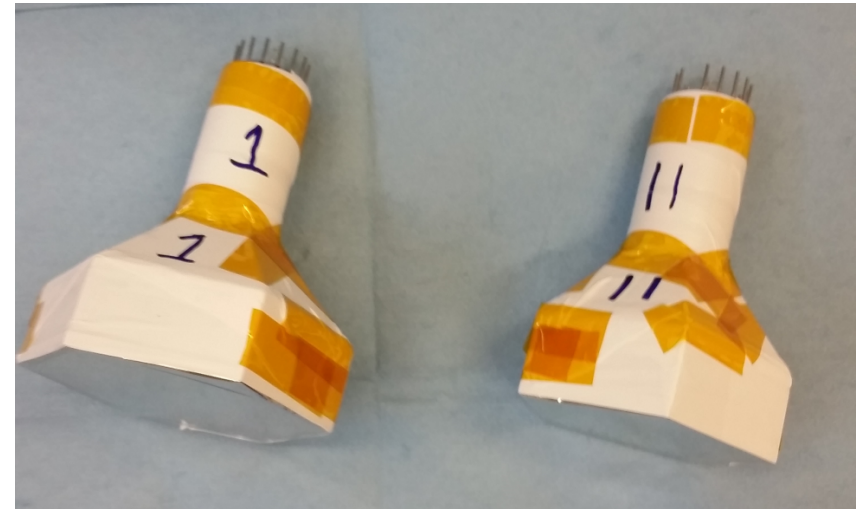
The ParTI Array

- $\approx 9''$ diameter
- 15 phoswiches
 - Each with own frame and angled tabs



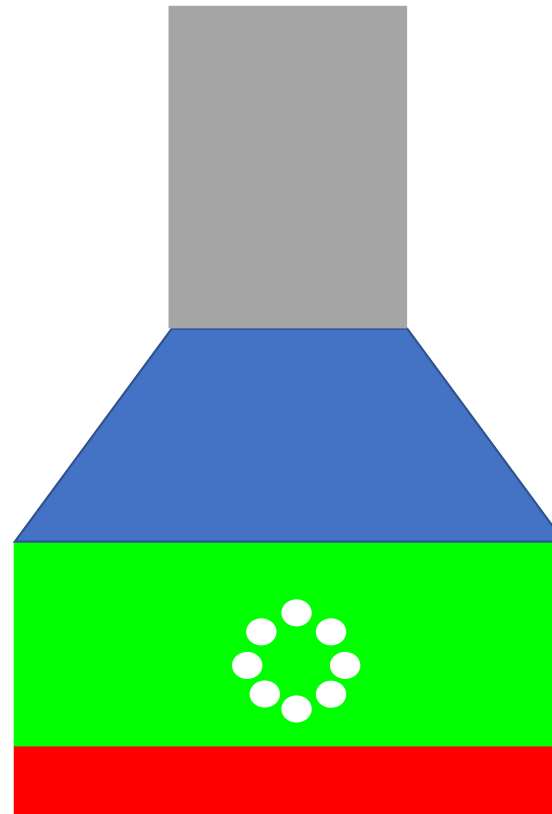
Phoswiches

- Phoswich – 2 scintillating components, PMT
 - EJ-212 scintillating plastic
 - Fast response
 - CsI(Tl) crystal
 - Slow response
- Sensitive to charged and neutral particles
 - PID by energy deposition in 2 components



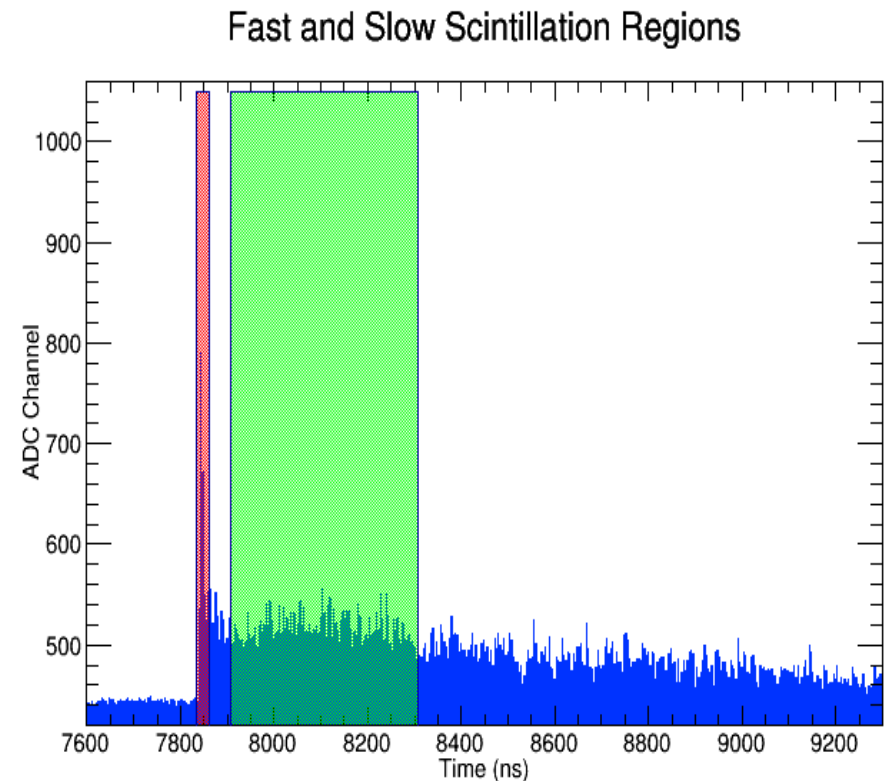
Particles and Phoswiches

- 1) Fast plastic (**red**)
- 2) Slow CsI(Tl) (**green**)
- 3) Light Guide (**blue**)
- 4) PMT (**grey**)
- 5) Particle from reaction (black)
- 6) Photons emitted from scintillators (**white**)



Fast and Slow Integration – How it works

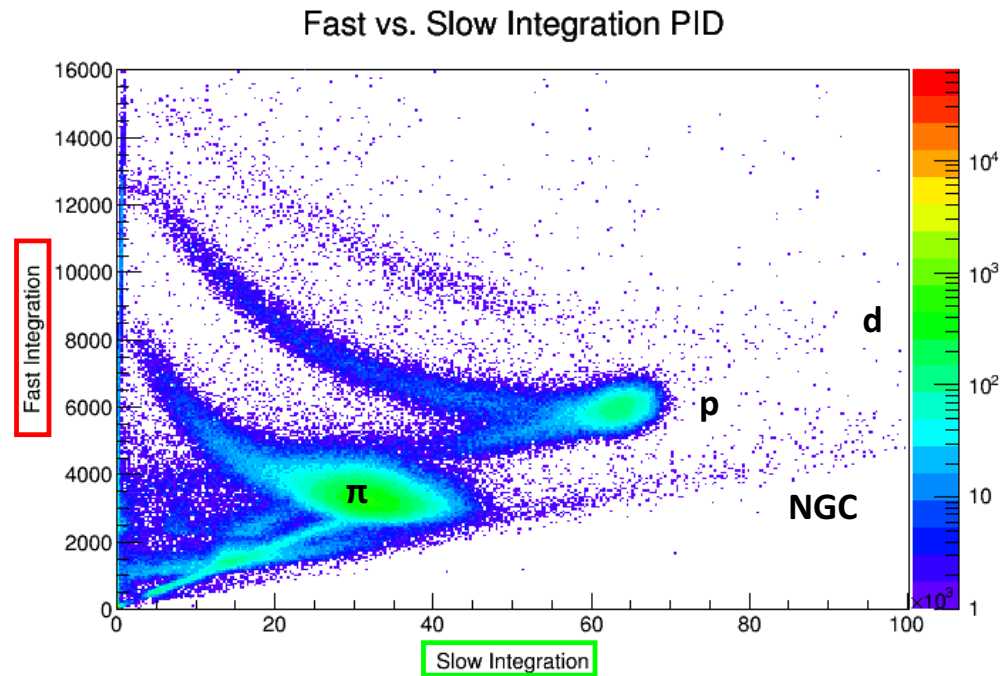
- Energy deposited by particles
 - Photon response
 - Photons converted to cascade of $e^{+/-}$
 - Voltage generated on PMT
 - Converted to counts of photons/time
- Each pulse has 2 regions
 - Fast (**red**)
 - Slow (**green**)
- Integrate area under each region



Fast vs. Slow Integration – PID

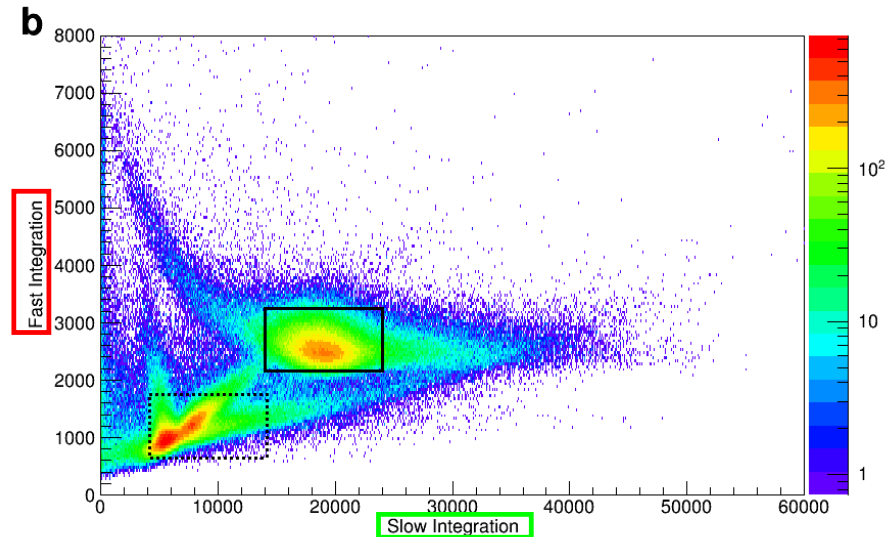
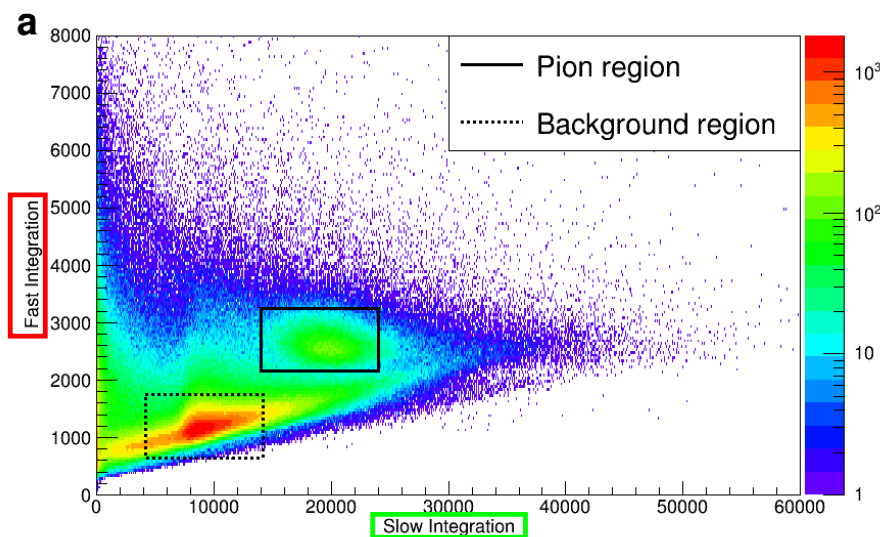
- Yields PID lines

- Based on relative energy lost
- Photons produced proportional to energy deposit
- Energy deposited unique to particle



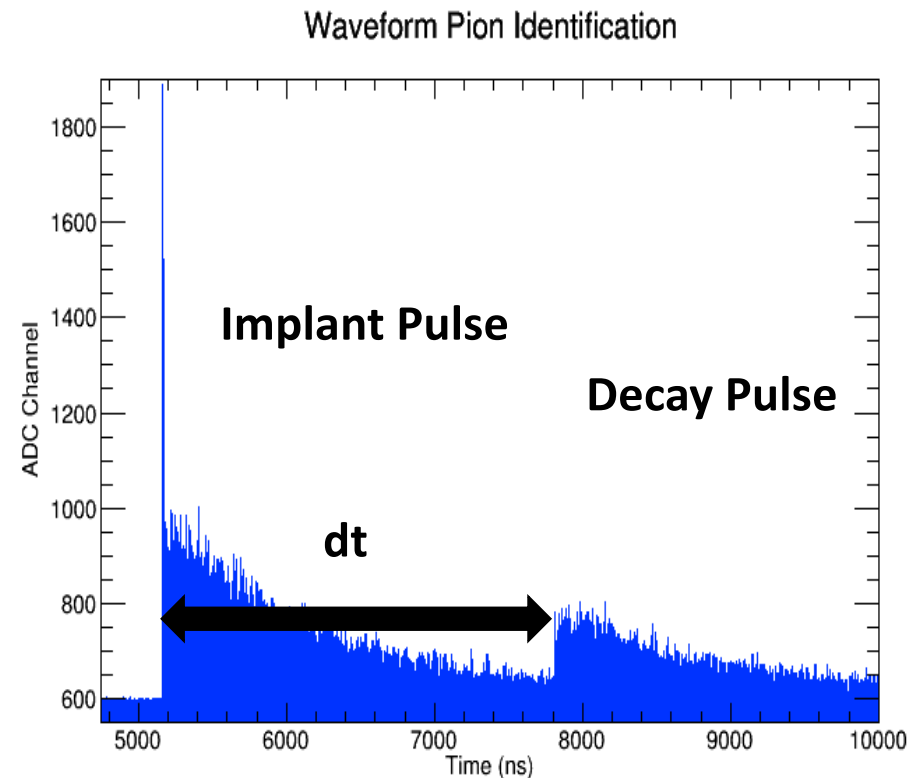
Muon Decay Trigger

- Implemented in place of a singles trigger
- Trigger occurs only on possible π -candidate events
 - Only if CFD is triggered 2nd time



Detecting π Through Digitized Waveforms

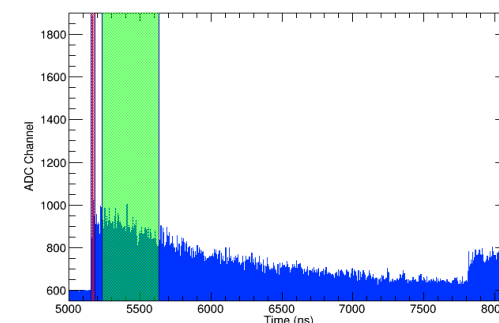
- π decay not easily detectable
 - 26 ns mean lifetime
 - 4.12 MeV energy deposit
- $\pi^+ \rightarrow \mu^+ + \nu_\mu \rightarrow e^+ + \nu_e + \bar{\nu}_\mu$
- $\pi^- \rightarrow \mu^- + \bar{\nu}_\mu \rightarrow e^- + \bar{\nu}_e + \nu_\mu$
 - 2197 ns μ mean lifetime
 - Up to 50 MeV energy deposit
 - 2nd pulse in waveform
 - Decay in detector
 - Difference = dt



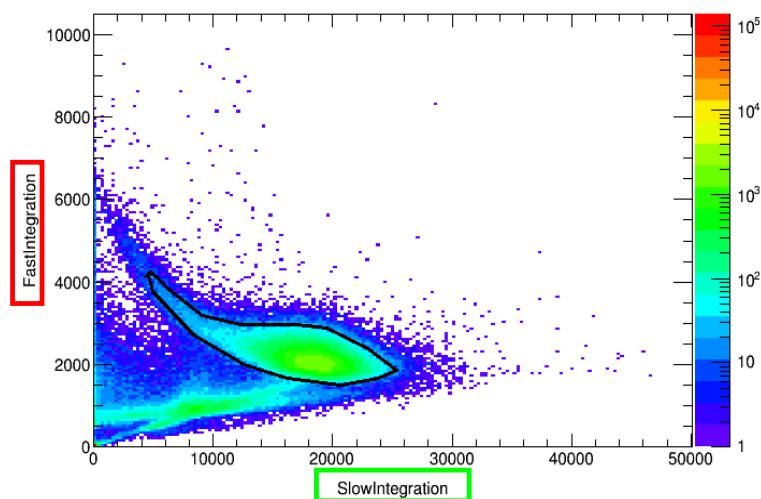
Fast vs. Slow Integration for Implant Pulse

- Cuts gate π section
 - Analyze π decay inside gate

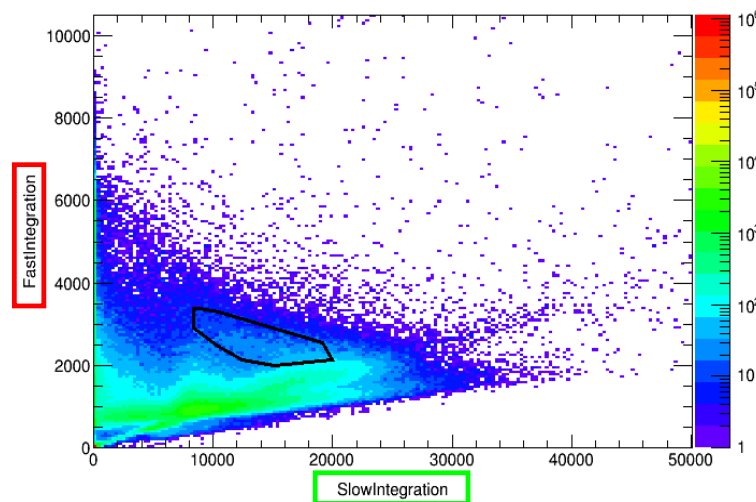
Waveform Pion Identification



Fast vs. Slow Integration π^+



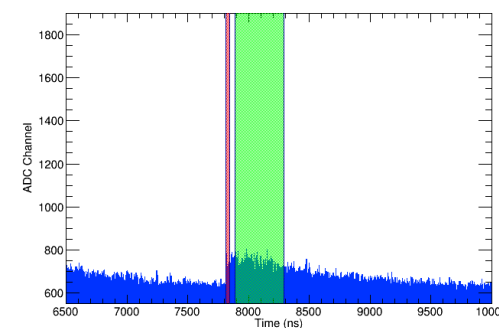
Fast vs. Slow Integration π^-



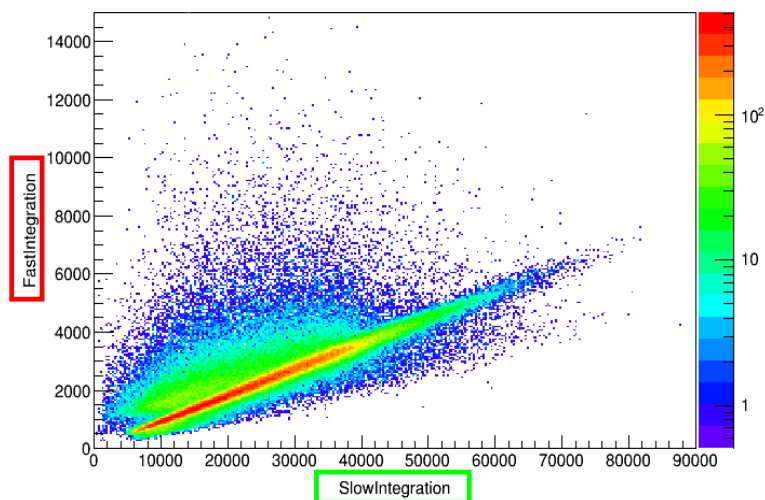
Fast vs. Slow Integration for Decay Pulse

- PSD on decay pulse
 - Possible way to ID π

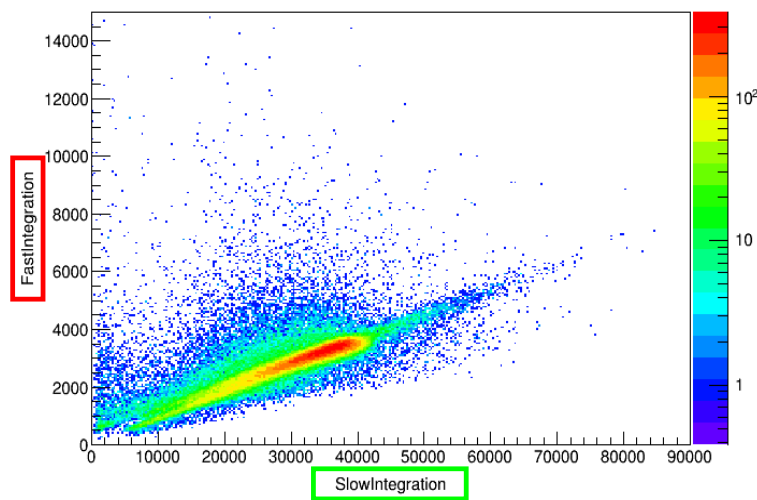
Waveform Pion Identification



Fast vs. Slow Integration π^+

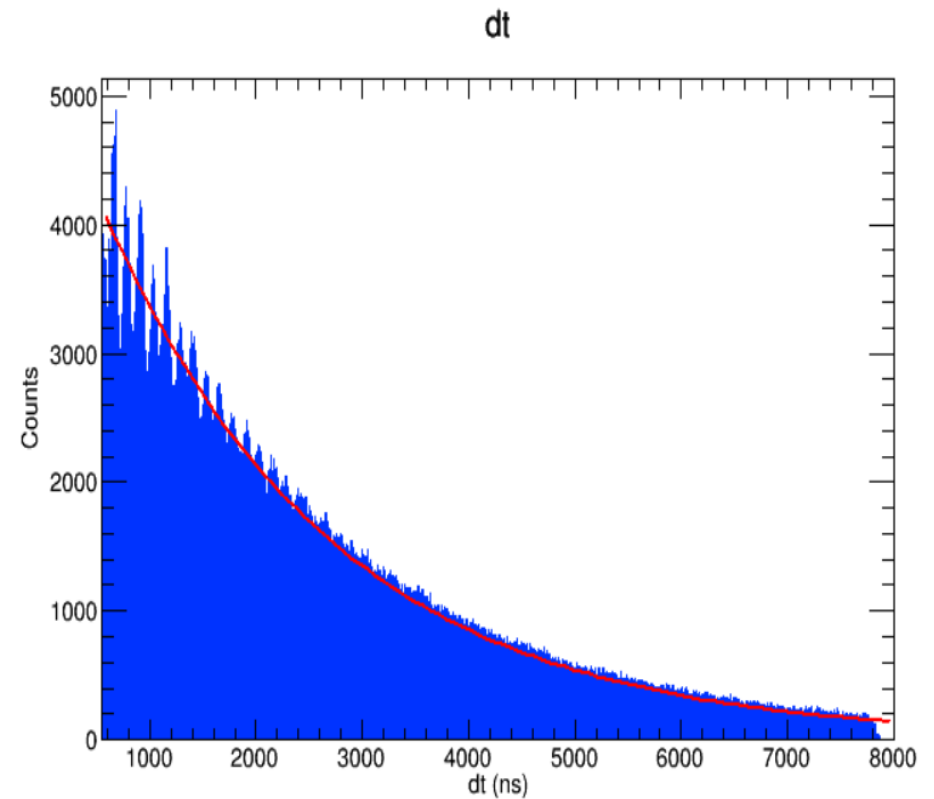


Fast vs. Slow Integration π^-



dt and Decay Curves for π^+

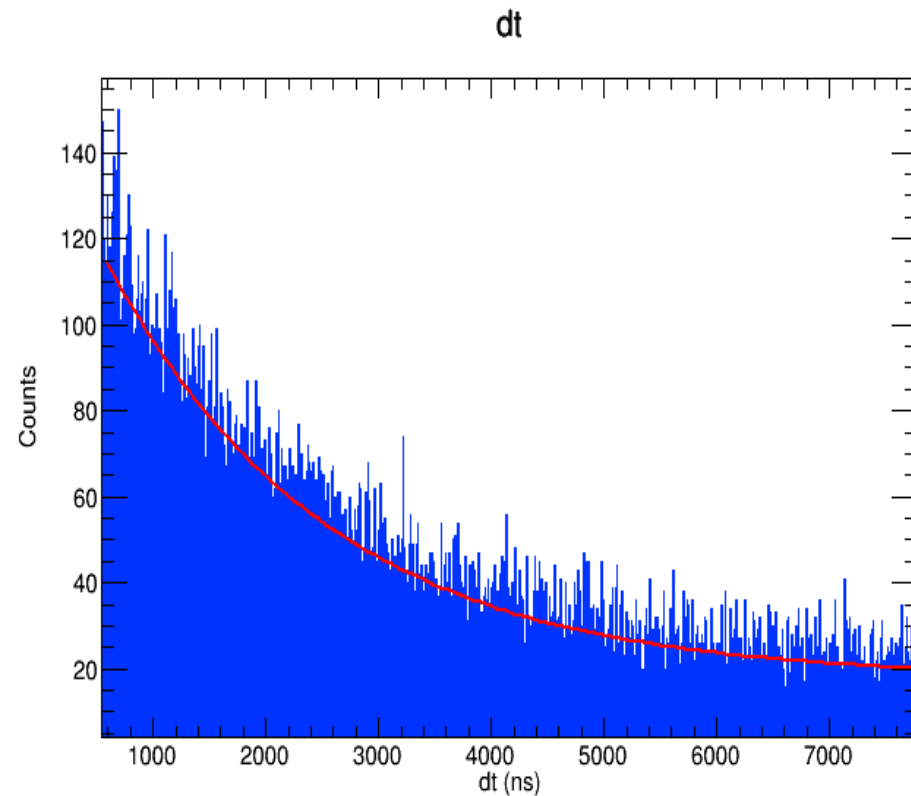
- dt corresponds to the time of survival for a muon
- Plotting dt
 - Exponential curve (red)
 - Generated decay constant
 - $\lambda_\mu = 4.55 \text{ E } -4 \text{ ns}^{-1}$
 - $\lambda_{\pi^+} = 4.57 \text{ E } -4 \pm 3.83 \text{ E } -7 \text{ ns}^{-1}$



dt and Decay Curves for π^-

- Generated decay constant

- $\lambda_\mu = 4.55 \text{ E-4 ns}^{-1}$
- $\lambda_{\pi^-} = 5.11 \text{ E-4} \pm 1.27 \text{ E-5 ns}^{-1}$



Mean Lifetime of the Decaying Particle

- Inverse of decay constant

- $\tau_\mu = 2197 \text{ ns}$ (red)

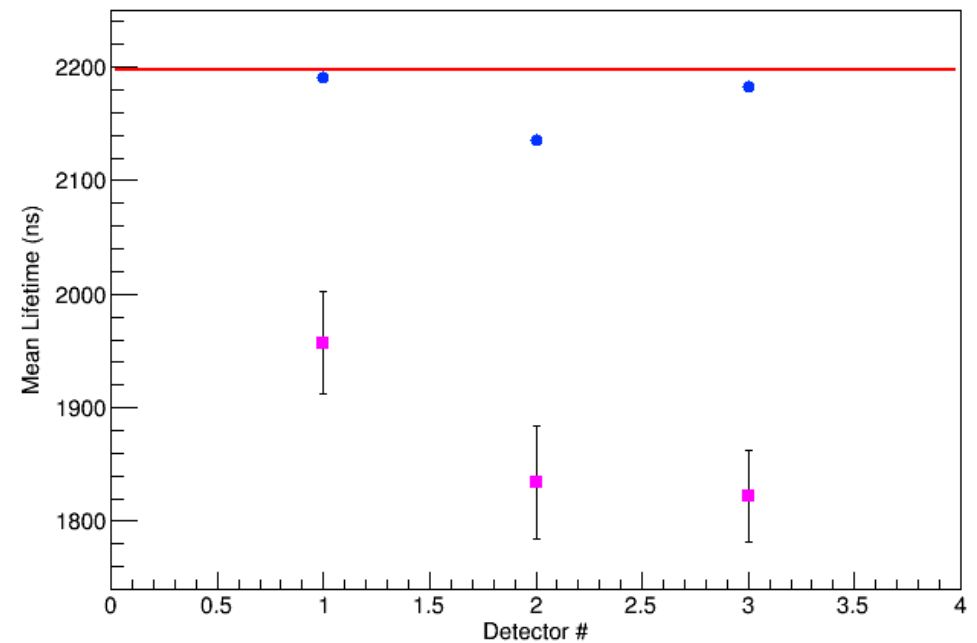
π^+ (blue)

$$\begin{aligned}\tau_1 &= 2190 \pm 2 \text{ ns} \\ \% error_1 &= 0.32\% \\ \tau_2 &= 2136 \pm 2 \text{ ns} \\ \% error_2 &= 2.78\% \\ \tau_3 &= 2182 \pm 3 \text{ ns} \\ \% error_3 &= 0.68\%\end{aligned}$$

π^- (magenta)

$$\begin{aligned}\tau_1 &= 1957 \pm 51 \text{ ns} \\ \% error_1 &= 10.9\% \\ \tau_2 &= 1832 \pm 47 \text{ ns} \\ \% error_2 &= 16.6\% \\ \tau_3 &= 1822 \pm 42 \text{ ns} \\ \% error_3 &= 17.1\%\end{aligned}$$

Mean Lifetime Comparison



Conclusions

- Using decay trigger increases the selectivity for π by an order of magnitude
- Fast vs. Slow PID methods for the phoswiches allow for π identification and separation from other light charged particles
- Decay curves for μ daughter can be reproduced by focusing on the π implant region to further identify the original presence of a π in its PID region

Acknowledgements

- I would like to thank Andrew Zarrella, Dr. Sherry Yennello, and Mike Youngs for their mentorship.
- The Cyclotron Institute at Texas A&M University
- The Department of Energy (DE-FG02-93ER40773)
- National Science Foundation (PHY – 1659847)
- The Welch Foundation (A-1266)